Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,605	INUI ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

	SEARCHED				
Class	Subclass	Date	Examiner		
427	162, 163.2, 165	6/18/2007	АВ		
430	321,394	6/18/2007	AB		
430	290	6/18/2007	ab		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST (attached)	6/18/2007	АВ
inventor and asignee search	6/18/2007	ab
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